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ALPHA & OMEGA SEMICONDUCTOR

AOTF6N90

900V,6A N-Channel MOSFET

General Description

The AOTF6N90 is fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications.By providing low $R_{DS(on)}$, C_{iss} and C_{rss} along with guaranteed avalanche capability this parts can be adopted quickly into new and existing offline power supply designs.

For Halogen Free add "L" suffix to part number: AOTF6N90L

Product Summary

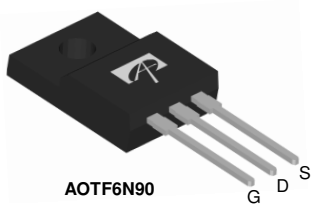
V_{DS}	1000V@150℃
I_D (at V_{GS}=10V)	6A
$R_{DS(ON)}$ (at V_{GS}=10V)	< 2.2Ω

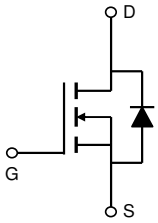
100% UIS Tested
100% R_g Tested

RoHS Compliant

Top View

TO-220F





Absolute Maximum Ratings T_A=25℃ unless otherwise noted

Parameter		Symbol	AOTF6N90	Units
Drain-Source Voltage		V_{DS}	900	V
Gate-Source Voltage		V_{GS}	±30	V
Continuous Drain Current	T_C=25℃	I_D	6*	A
	T_C=100℃		3.9*	
Pulsed Drain Current [C]		I_{DM}	24	
Avalanche Current [C]		I_{AR}	3.3	A
Repetitive avalanche energy [C]		E_{AR}	80	mJ
Single plused avalanche energy [G]		E_{AS}	160	mJ
Peak diode recovery dv/dt		dv/dt	5	V/ns
Power Dissipation [B]	T_C=25℃	P_D	50	W
	Derate above 25°C		0.4	W/ °C
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	℃
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds		T_L	300	℃

Thermal Characteristics

Parameter	Symbol	AOTF6N90	Units
Maximum Junction-to-Ambient [A,D]	$R_{\theta JA}$	65	℃/W
Maximum Junction-to-Case	$R_{\theta JC}$	2.5	℃/W

* Drain current limited by maximum junction temperature.

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I_D=250µA, V_{GS}=0V, T_J=25°C	900			V
		I_D=250µA, V_{GS}=0V, T_J=150°C		1000		
BV_{DSS} /ΔTJ	Zero Gate Voltage Drain Current	ID=250µA, VGS=0V		1		V/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=900V, V_{GS}=0V			1	µA
		V_{DS}=720V, T_J=125°C			10	
I_{GSS}	Gate-Body leakage current	V_{DS}=0V, V_{GS}=±30V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=5V I_D=250µA	3.4	4.1	4.5	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS}=10V, I_D=3A		1.74	2.2	Ω
g_{FS}	Forward Transconductance	V_{DS}=40V, I_D=3A		8		S
V_{SD}	Diode Forward Voltage	I_S=1A,V_{GS}=0V		0.73	1	V
I_S	Maximum Body-Diode Continuous Current				6	A
I_{SM}	Maximum Body-Diode Pulsed Current				24	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=25V, f=1MHz	955	1196	1450	pF
C_{oss}	Output Capacitance		65	82	110	pF
C_{rss}	Reverse Transfer Capacitance		6	7.8	12	pF
R_g	Gate resistance	V_{GS}=0V, V_{DS}=0V, f=1MHz	1.7	3.4	5.1	Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	V_{GS}=10V, V_{DS}=720V, I_D=6A	23	29	35	nC
Q_{gs}	Gate Source Charge		5.5	7	8.5	nC
Q_{gd}	Gate Drain Charge		10	13	20	nC
$t_{D(on)}$	Turn-On DelayTime	V_{GS}=10V, V_{DS}=450V, I_D=6A, R_G=25Ω		30		ns
t_r	Turn-On Rise Time			58		ns
$t_{D(off)}$	Turn-Off DelayTime			70		ns
t_f	Turn-Off Fall Time			49		ns
t_{rr}	Body Diode Reverse Recovery Time	I_F=6A,dI/dt=100A/µs,V_{DS}=100V	230	286	343	ns
Q_{rr}	Body Diode Reverse Recovery Charge	I_F=6A,dI/dt=100A/µs,V_{DS}=100V	4.5	5.6	6.7	µC

A. The value of $R_{\theta JA}$ is measured with the device in a still air environment with T_A =25°C.

B. The power dissipation P_D is based on $T_{J(MAX)}$=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$=150°C, Ratings are based on low frequency and duty cycles to keep initial T_J =25°C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$=150°C. The SOA curve provides a single pulse ratin g.

G. L=30mH, I_{AS}=3.3A, V_{DD}=150V, R_G=25Ω, Starting T_J=25°C

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

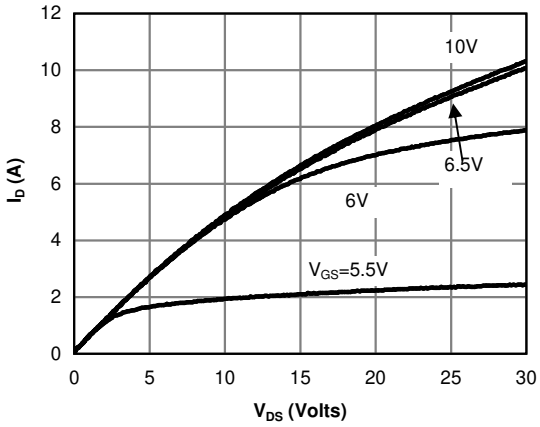


Fig 1: On-Region Characteristics

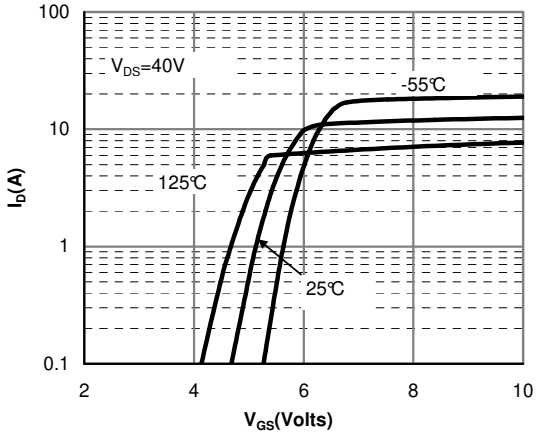


Figure 2: Transfer Characteristics

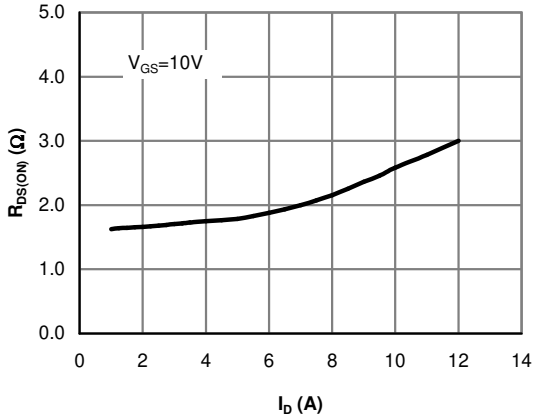


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

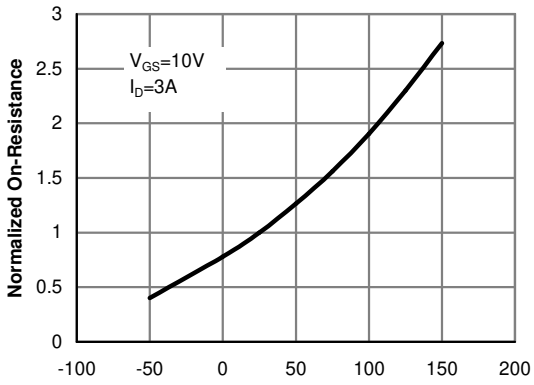


Figure 4: On-Resistance vs. Junction Temperature

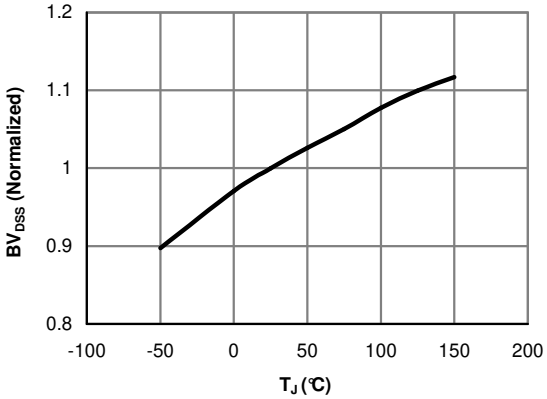


Figure 5:Break Down vs. Junction Temparature

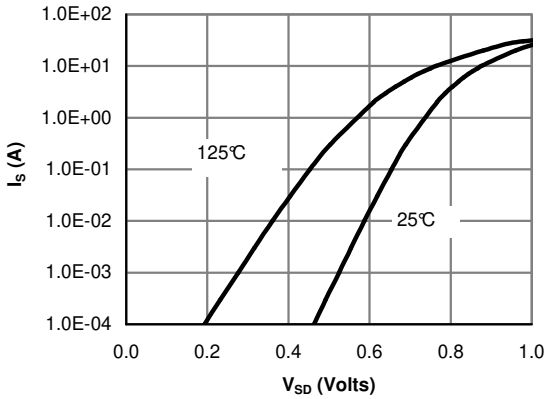


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

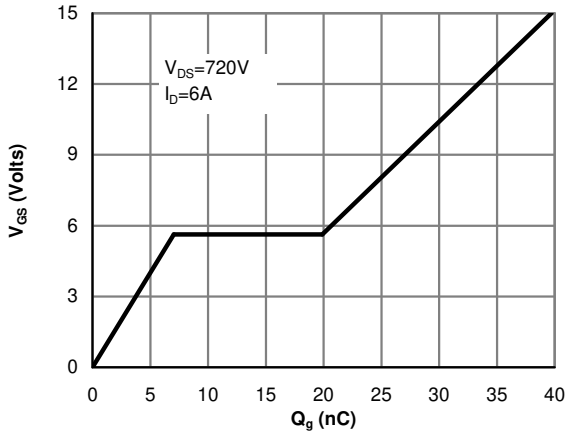


Figure 7: Gate-Charge Characteristics

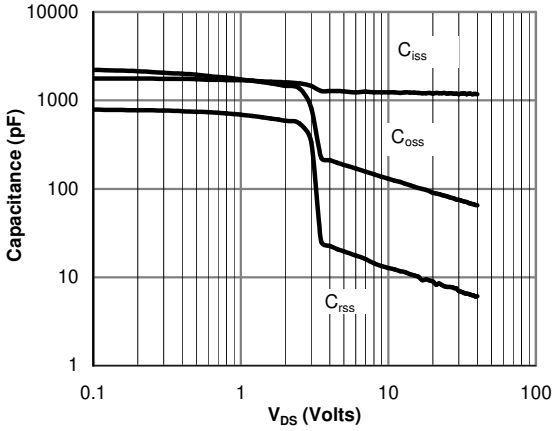


Figure 8: Capacitance Characteristics

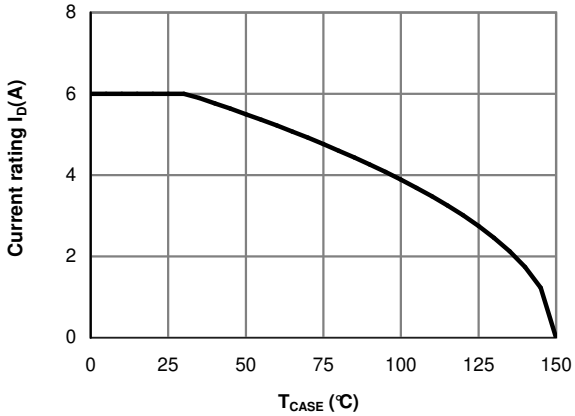


Figure 9: Current De-rating (Note B)

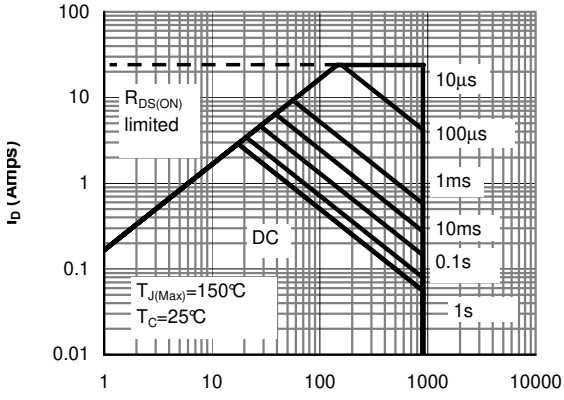


Figure 10: Maximum Forward Biased Safe Operating Area for AOTF6N90 (Note F)

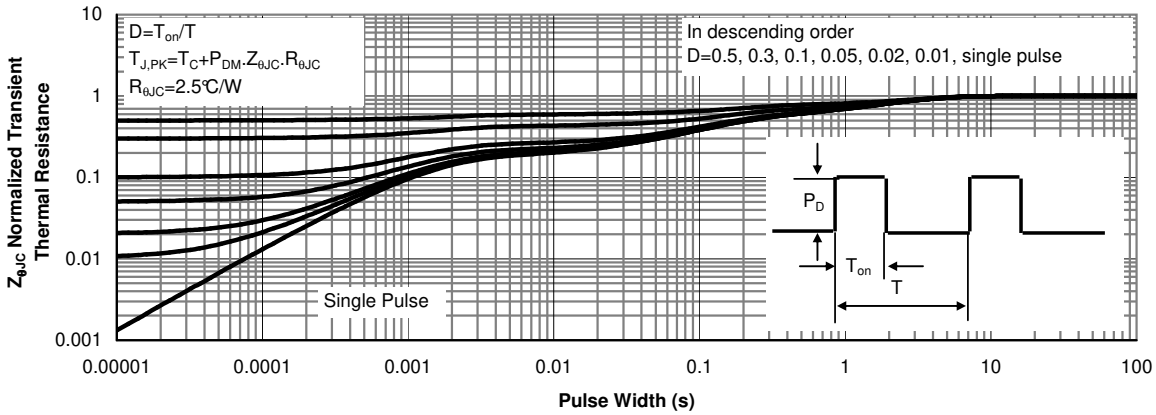
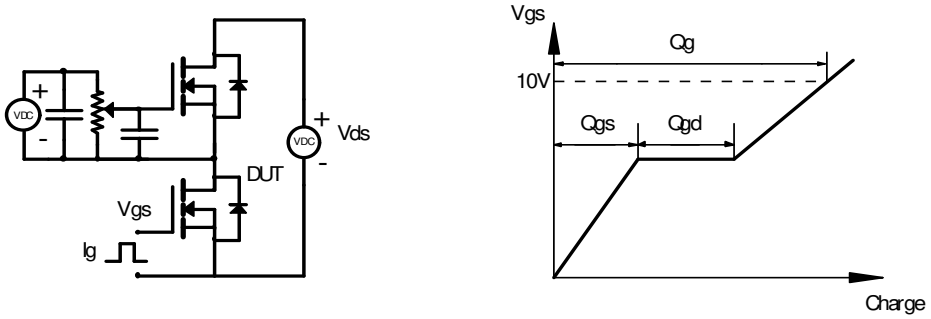
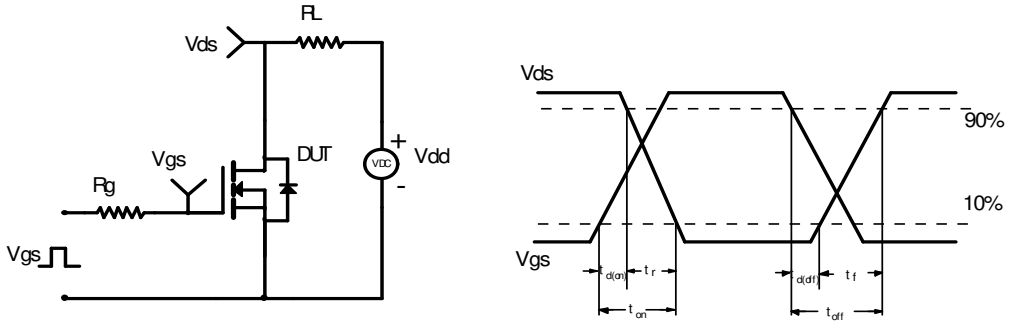


Figure 11: Normalized Maximum Transient Thermal Impedance for AOTF6N90 (Note F)

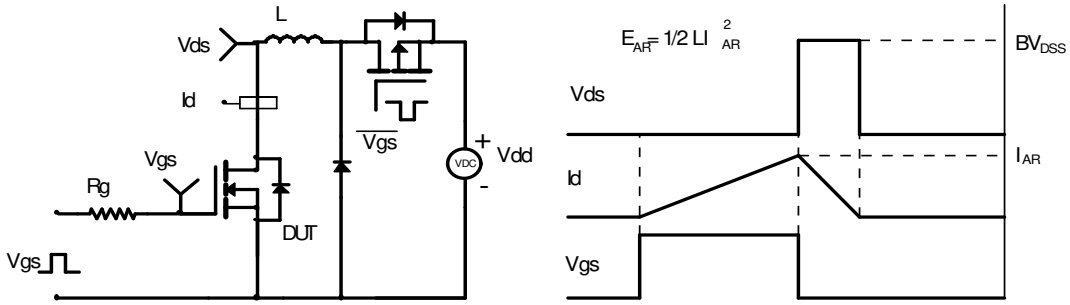
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms